# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination ROTHAN ET AL. | Examiner | Art Unit | Page 1 of 3

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2,151,485	03-1939	REUBEN PAWSAT	362/473
	В	US-3,834,423	09-1974	Elson, Arthur M.	138/122
	С	US-3,889,717	06-1975	Obadal et al.	138/131
[.	D	US-3,890,033	06-1975	McGee, Kevin	359/227
	Ε	US-4,005,874	02-1977	Ohtani, Tadakatsu	280/288.4
	F	US-4,047,150	09-1977	Kelley, Dale T.	340/473
	G	US-4,088,882	05-1978	Lewis, Donald J.	362/217
	Н	US-4,204,191	05-1980	Daniels, Travis J.	340/432
	1	US-4,215,390	07-1980	Brandt, Ivan L.	362/311
	J	US-4,325,108	04-1982	Spingler, Werner	362/183
	Ķ	US-4,422,719	12-1983	Orcutt, Donald E.	385/123
	L	US-4,715,681	12-1987	Johnson, William M.	359/526
	М	US-4,814,951	03-1989	Larsen, Herluf J.	362/473

#### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited

Application/Control No. 10/733,875	Reexaminati	Applicant(s)/Patent Under Reexamination ROTHAN ET AL.			
Examiner	Art Unit				
Jason M Han	2875	Page 2 of 3			

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,819,135	04-1989	Padilla et al.	362/473
	В	US-5,197,795	03-1993	Mudrovich, George	362/473
	С	US-5,276,593	01-1994	Lighthill et al.	362/473
	D	US-5,526,240	06-1996	Kuo, Kuan-Ju	362/473
	Ε	US-5,618,052	04-1997	Rendall, Barry A.	280/288.4
	F	US-5,823,653	10-1998	Elam et al.	362/473
	G	US-5,871,269	02-1999	Chien, Tseng Lu	362/474
	Н	US-6,017,335	01-2000	Burnham, Warren R.	604/527
		US-6,031,958	02-2000	McGaffigan, Thomas H.	385/146
	J	US-6,139,174	10-2000	Butterworth, Mark M.	362/555
	К	US-6,158,881	12-2000	Carne, Steven Andrew	362/473
	L	US-6,249,372	06-2001	Kobayashi et al.	359/326
	М	US-6,417,019	07-2002	Mueller et al.	438/29

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination ROTHAN ET AL. | Examiner | Art Unit | Page 3 of 3

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,459,919	10-2002	Lys et al.	600/407
	В	US-6,517,213	02-2003	Fujita et al.	362/84
	С	US-6,533,438	03-2003	Ter-Hovhannisian, Artak	362/276
	D	US-2003/0133311	07-2003	Robertson et al.	362/555
	Е	US-2003/0155856	08-2003	Shiiki et al.	313/483
	F	US-2004/0095776	05-2004	Pisula, Richard L.	362/473
	G	US-6,779,913	08-2004	Niezrecki et al.	362/473
	Н	US-			
	ı	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

### FOREIGN PATENT DOCUMENTS

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#### NON-PATENT DOCUMENTS

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.